

# Search Notes



Application/Control No.

10/671,309

Examiner

Mark Kopec

Applicant(s)/Patent under  
Reexamination

HAYAKAWA ET AL.

Art Unit

1751

## SEARCHED

Class	Subclass	Date	Examiner
252	512	9/16/2005	M.K.
252	513		
338	22R		
427	96		
ABOVE TO DATE 2/2/06 m			

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
P6 PUB		2/2/06	m

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
WEST	9/16/2005	M.K.
Inv. Name Search		